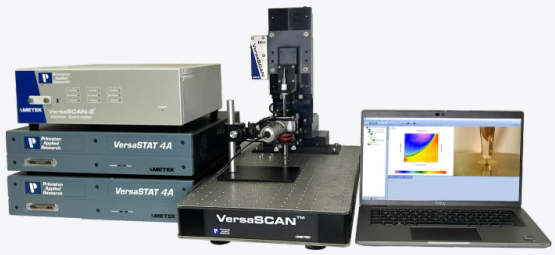
AMETEK SI · PRINCETON APPLIED RESEARCH

VersaSCAN VS-BASE

Scanning electrochemistry

VersaSCAN VS-BASE by Princeton Applied Research. Scanning electrochemistry. Required equipment and compatibility: Separate measurement components selected for SECM, LEIS, SVET, SKP, SDC or OSP.



X travel	Y travel	Z travel
100 mm [1]	**100 mm** [1]	**100 mm** [1]

Specifications

X travel	100 mm	[1]
Y travel	100 mm	[1]
Z travel	100 mm	[1]
Motors	Piezoelectric motors on every axis	[1]
Measurement equipment	Separate measurement components selected for SECM, LEIS, SVET, SKP, SDC or OSP	[2]

Sources

[1] **VSC-SECM (DC and AC) Scanning Electrochemical Microscope**
AMETEK Scientific Instruments · product-page · Differentiated Specifications – 'VersaSCAN Positioning System'; Overview – Positioning System; spec table · checked 2026-10-16
https://www.ameteksi.com/products/scanningelectrochemicalsystems/secm-scanning-electrochemical-microscopy

[2] **VersaSCAN Electrochemical Scanning System (brochure, A4, 26-0511)**
AMETEK Scientific Instruments · brochure · p. 2, 'Introducing... the VersaSCAN' · checked 2026-10-16
https://www.ameteksi.com/-/media/ameteksi/download_links/documentations/versascan-brochure/versascan-brochur...

Every value is taken from the manufacturer’s own document; the number after the value refers to the source list. Always check against the latest datasheet before ordering.

The data comes from the manufacturer’s published documents. Manufacturers may change specifications; the current configuration and performance are confirmed in the quotation.